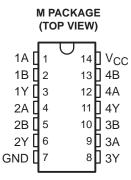
- Controlled Baseline
  - One Assembly/Test Site, One Fabrication Site
- Extended Temperature Performance of Up To -55°C to 125°C
- Enhanced Diminishing Manufacturing Sources (DMS) Support
- Enhanced Product-Change Notification
- Qualification Pedigree<sup>†</sup>
- Buffered Inputs
- Typical Propagation Delay 7 ns at V<sub>CC</sub> = 5 V, C<sub>L</sub> = 15 pF, T<sub>A</sub> = 25°C
- Fanout (Over Temperature Range)
  - Standard Outputs ... 10 LSTTL Loads
  - Bus Driver Outputs ... 15 LSTTL Loads
- † Component qualification in accordance with JEDEC and industry standards to ensure reliable operation over an extended temperature range. This includes, but is not limited to, Highly Accelerated Stress Test (HAST) or biased 85/85, temperature cycle, autoclave or unbiased HAST, electromigration, bond intermetallic life, and mold compound life. Such qualification testing should not be viewed as justifying use of this component beyond specified performance and environmental limits.

- Balanced Propagation Delay and Transition Times
- Significant Power Reduction Compared to LSTTL Logic ICs
- 2-V to 6-V V<sub>CC</sub> Operation
- High Noise Immunity N<sub>IL</sub> or N<sub>IH</sub> = 30% of V<sub>CC</sub> at V<sub>CC</sub> = 5 V
- CMOS Input Compatibility,  $I_l \le 1 \mu A$  at  $V_{OL}$ ,  $V_{OH}$



# description/ordering information

The CD74HC08 logic gates utilize silicon-gate CMOS technology to achieve operating speeds similar to LSTTL gates, with the low power consumption of standard CMOS integrated circuits. All devices can drive 10 LSTTL loads.

#### ORDERING INFORMATION

TA	PACKA	GE‡	ORDERABLE PART NUMBER	TOP-SIDE MARKING	
-40°C to 125°C	SOIC - M	Tape and reel	CD74HC08QM96EP	HC08QEP	
-55°C to 125°C	SOIC - M	Tape and reel	CD74HC08MM96EP§	HC08MEP	

<sup>&</sup>lt;sup>‡</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

# FUNCTION TABLE (each gate)

_		(	,
	INP	UTS	OUTPUT
	Α	В	Υ
ľ	Н	Н	Н
	L	Χ	L
	X	L	L



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



<sup>§</sup> Product Preview

# logic diagram (positive logic)



# absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, $V_{CC}$	
Output clamp current, $I_{OK}$ ( $V_O < -0.5 \text{ V}$ or $V_O > V_{CC} + 0.5 \text{ V}$ ) (see Note 1)	
Continuous output current, $I_O$ ( $V_O > -0.5$ or $V_O < V_{CC} + 0.5$ V)	±25 mA
Continuous current through V <sub>CC</sub> or GND	±50 mA
Package thermal impedance, θ <sub>JA</sub> (see Note 2)	180°C/W
Maximum junction temperature, T <sub>J</sub>	150°C
Lead temperature (during soldering):	
At distance $1/16 \pm 1/32$ inch $(1,59 \pm 0,79 \text{ mm})$ from case for 10 s max	300°C
Storage temperature range, T <sub>stg</sub>	–65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

# recommended operating conditions (see Note 3)

			MIN	NOM	MAX	UNIT
VCC	Supply voltage		2	5	6	V
		$V_{CC} = 2 V$	1.5			
ViH	High-level input voltage	$V_{CC} = 4.5 \text{ V}$	3.15			V
		$V_{CC} = 6 V$	4.2			1 1
		$V_{CC} = 2 V$			0.5	
VIL	Low-level input voltage	$V_{CC} = 4.5 \text{ V}$			1.35	V
		$V_{CC} = 6 V$			1.8	
VI	Input voltage		0		VCC	V
VO	Output voltage		0		VCC	V
		V <sub>CC</sub> = 2 V			1000	
Δt/Δν	Input transition rise/fall time	$V_{CC} = 4.5 \text{ V}$			500	ns
		V <sub>CC</sub> = 6 V			400	
т.	Operating free air temperature	Q suffix	-40		125	°C
TA	Operating free-air temperature	M suffix	-55		125	°C

NOTE 3: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>2.</sup> The package thermal impedance is calculated in accordance with JESD 51-7.

### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

24244555	7507.00	TEST CONDITIONS			T,	<b>Վ = 25°C</b>	;			
PARAMETER	TEST COI	NDITIONS	I <sub>O</sub>	VCC	MIN	TYP	MAX	MIN	MAX	UNIT
			-0.02	2 V	1.9			1.9		
	$V_{OH}$ $V_{I} = V_{IH} \text{ or } V_{IL}$	CMOS loads	-0.02	4.5 V	4.4			4.4		
Voн			-0.02	6 V	5.9			5.9		V
		TTL loads	-4	4.5 V	3.98			3.7		
			-5.2	6 V	5.48			5.2		
			0.02	2 V			0.1		0.1	
		CMOS loads	0.02	4.5 V			0.1		0.1	
VOL	VI = VIH or VIL		0.02	6 V			0.1		0.1	V
		TTI locale	4	4.5 V			0.26		0.4	
		I I L loads	TTL loads 5.2	6 V			0.26		0.4	
lį	$V_I = V_{CC}$ or GND			6 V			±0.1		±1	μΑ
Icc	$V_I = V_{CC}$ or GND	•	0	6 V			2		40	μΑ
Ci							10		10	pF

# switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

DADAMETED	FROM	то	CONDITIONS	, , , , , , , , , , , , , , , , , , ,	T,	4 = 25°C	;	MANN	MAY	LINUT			
PARAMETER	(INPUT)	(OUTPUT)	CONDITIONS	vcc	MIN	TYP	MAX	MIN	MAX	UNIT			
		Y		2 V			90		135				
	A == D		Υ	Y C <sub>L</sub> = 50 pF	C <sub>L</sub> = 50 pF	4.5 V			18		27		
<sup>t</sup> pd	A or B				ī	' <u> </u>				6 V			15
			C <sub>L</sub> = 15 pF	5 V		7							
				2 V			75		110				
t <sub>t</sub>	A or B	Y	C <sub>L</sub> = 50 pF	C <sub>L</sub> = 50 pF	4.5 V			15		22	ns		
				6 V			13		19				

# operating characteristics, $T_A = 25$ °C, $V_{CC} = 5V$

	PARAMETER	TEST CONDITIONS	TYP	UNIT
C <sub>pd</sub>	Power dissipation capacitance per gate (see Note 4)	No load	37	pF

NOTE 4:  $C_{pd}$  is used to determine the dynamic power consumption, per gate.

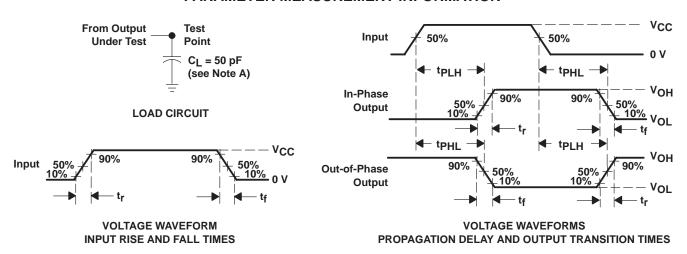
 $P_D^{pd} = V_{CC}^2 f_I (C_{pd} + C_L)$ 

 $f_I$  = input frequency  $C_L$  = output load capacitance

V<sub>CC</sub> = supply voltage



### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>L</sub> includes probe and test-fixture capacitance.

- B. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>f</sub> = 6 ns, t<sub>f</sub> = 6 ns.
- C. The outputs are measured one at a time, with one input transition per measurement.
- D. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms





# PACKAGE OPTION ADDENDUM

10-Dec-2020

#### PACKAGING INFORMATION

www.ti.com

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
CD74HC08QM96EP	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HC08QEP	Samples
V62/04704-01XE	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HC08QEP	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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# **PACKAGE OPTION ADDENDUM**

10-Dec-2020

#### OTHER QUALIFIED VERSIONS OF CD74HC08-EP:

www.ti.com

• Automotive: CD74HC08-Q1

• Military: CD54HC08

#### NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Military QML certified for Military and Defense Applications

# **PACKAGE MATERIALS INFORMATION**

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# TAPE AND REEL INFORMATION





		Dimension designed to accommodate the component width
		Dimension designed to accommodate the component length
	K0	Dimension designed to accommodate the component thickness
	W	Overall width of the carrier tape
1	P1	Pitch between successive cavity centers

# QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



### \*All dimensions are nominal

Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74HC08QM96EP	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1

www.ti.com 27-Jul-2021



### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74HC08QM96EP	SOIC	D	14	2500	340.5	336.1	32.0

# D (R-PDSO-G14)

# PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.



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